

Push-Pull Output Sub-Microamp Comparators

Description

The Microchip Technology Inc. HT6541/2/3/4 family of comparators is offered in single (HT6541), single with chip select (HT6543), dual (HT6542) and quad (HT6544) configurations. The outputs are push-pull (CMOS/TTL-compatible) and are capable of driving heavy DC or capacitive loads.These comparators are optimized for low power, single-supply operation with greater than rail-to-rail input operation. The push-pull output of the HT6541/2/3/4 family supports rail-to-rail output swing and interfaces with TTL/CMOS logic. The internal input hysteresis eliminates output switching due to internal input noise voltage, reducing current draw. The output limits supply current surges and dynamic power consumption while switching. This product family operates with a single-supply voltage as low as 1.6V and draws less than 1 µA/ comparator of quiescent

current.The related HT6546/7/8/9 family of comparators from Microchip has an open-drain output. Used with a pull-up resistor, these devices can be used as level-shifters for any desired voltage up to 10V and in wired-OR logic.

Features

- Low Quiescent Current: 600 nA/comparator (typ.)
- Rail-to-Rail Input: V_{SS} 0.3V to V_{DD} + 0.3V
- CMOS/TTL-Compatible Output
- Propagation Delay 4 µs (typ.)
- Wide Supply Voltage Range: 1.6V to 5.5V
- Available in Single, Dual and Quad
- Single available in SOT-23-5, SC-70-5 packages
- Chip Select (CS) with HT6543
-
- Internal Hysteresis: 3.3 mV (typ.)
- Industrial Temperature: -40°C to +85°C

Typical Applications

- Laptop Computers
- Mobile Phones
- Metering Systems
- Hand-held Electronics
- RC Timers
- Alarm and Monitoring Circuits
- Windowed Comparators
- Multi-vibrators

Related Devices

• Open-Drain Output: HT6546/7/8/9

1.1 ELECTRICAL CHARACTERISTICS

1.2 Absolute Maximum Ratings †

† Notice: Stresses above those listed under "Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

PINFUNCTIONTABLE

DC CHARACTERISTICS

Electrical Specifications: Unless otherwise indicated, $V_{DD} = +1.6V$ to $+5.5V$, $V_{SS} = GND$, $T_A = +25^{\circ}C$, $V_{IN} = V_{DD}/2$, $V_{IN} = V_{DD}/2$, $V_{IN} = 100$ kg to $V_{IN}/2$, P_{IN} (Peter to Figure 1.3) V_{IN} = V_{SS} , and R_L = 100 kΩ to $V_{\text{DD}}/2$ (Refer to Figure 1-3).

Note 1: The input offset voltage is the center (average) of the input-referred trip points. The input hysteresis is the difference between the input-referred trip points.

2: Limit the output current to Absolute Maximum Rating of 30 mA.

3: Input bias current over temperature is not tested for SC-70-5 package.

AC CHARACTERISTICS

Electrical Specifications: Unless otherwise indicated, V_{DD}=+1.6V to +5.5V, V_{SS}=GND, T_A=+25°C, V_{IN}+=V_{DD}/2, Step = 200 mV, Overdrive = 100 mV, and C_L = 36 pF (Refer to Figure 1-2 and Figure 1-3).

Note 1: Propagation Delay Skew is defined as: $t_{PDS} = t_{PLH} - t_{PHL}$.

SPECIFICATIONS FOR HT6543 CHIP-SELECT

Electrical Specifications: Unless otherwise indicated, V_{DD}=+1.6V to+5.5V, V_{SS}=GND, T_A=+25°C, V_{IN}+=V_{DD}/2, V_{IN}-=V_{SS}, and C_l = 36 pF (Refer to Figures [1-1](#page-2-0) and [1-3\).](#page-3-0)

FIGURE 1-1: Timing Diagram for the CS Pin on theHT6543.

FIGURE1-2: PropagationDelayTiming Diagram.

TEMPERATURE SPECIFICATIONS

Note: The HT6541/2/3/4 operates over this extended temperature range, but with reduced performance. In any case, the Junction Temperature (T_J) must not exceed the Absolute Maximum specification of $+150^{\circ}$ C.

1.3 Test Circuit Configuration

This test circuit configuration is used to determine the AC and DC specifications.

FIGURE 1-3: AC and DC Test Circuit for the Push-Pull Output Comparators.

2.0 TYPICAL PERFORMANCECURVES

Note: The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range (e.g., outside specified power supply range) and therefore outside the warranted range.

Note: Unless otherwise indicated, $V_{DD} = +1.6V$ to $+5.5V$, $V_{SS} = GND$, $T_A = +25°C$, $V_{IN} + V_{DD}/2$, $V_{IN} - V_{ND}$, $V_{IN} = GND$, R_L = 100 k Ω to $V_{DD}/2$, and C_L = 36 pF.

FIGURE 2-2: Input Offset Voltage Drift Histogram at $V_{CM} = V_{SS}$ *.*

FIGURE 2-3: Input Offset Voltage vs. Ambient Temperature at VCM = VSS.

FIGURE 2-4: Input Hysteresis Voltage Histogram at $V_{CM} = V_{SS}$ *.*

FIGURE 2-5: Input Hysteresis Voltage Drift Histogram.

FIGURE 2-6: Input Hysteresis Voltage vs. Ambient Temperature at VCM = VSS.

FIGURE 2-9: CMRR, PSRR vs.Ambient Temperature at $V_{CM} = V_{SS}$ *.*

FIGURE2-10: Input Hysteresis Voltage vs. Common Mode Input Voltage at $V_{DD} = 1.6V$.

FIGURE2-12: Input Bias Current,Input Offset Current vs. Common Mode Voltage at +85°C.

Note: Unless otherwise indicated, $V_{DD} = +1.6V$ to $+5.5V$, $V_{SS} = GND$, $T_A = +25°C$, $V_{IN} = V_{DD}/2$, $V_{IN} = GND$, R_L = 100 k Ω to $V_{DD}/2$, and C_L = 36 pF.

FIGURE 2-13: Input Bias Current, Input *Offset Current vs. Ambient Temperature.*

FIGURE 2-14: Quiescent Currentvs. Ambient Temperature.

FIGURE 2-16: Quiescent Currentvs. Power SupplyVoltage.

FIGURE 2-17: Quiescent Currentvs. Common Mode Input Voltage at $V_{DD} = 5V$.

FIGURE 2-18: OutputShort-CircuitCurrent vs. Power Supply Voltage.

 R_L = 100 k Ω to $V_{DD}/2$, and C_L = 36 pF.

1.0 $V_{DD} = 1.6V$ **0.9** ε **0.8** Voltage Headroom **0.7 VOL-VSS, T^A = -40°C 0.6 VOL-VSS, T^A = +25°C 0.5 VOL-VSS, T^A = +85°C 0.4 0.3 VDD-VOH, T^A = +85°C VDD-VOH, T^A = +25°C 0.2 VDD-VOH, T^A = -40°C 0.1 0.0 0.0 0.5 1.0 1.5 2.0 2.5 Output Current (mA)**

Note: Unless otherwise indicated, $V_{DD} = +1.6V$ to $+5.5V$, $V_{SS} = GND$, $T_A = +25°C$, $V_{IN} = V_{DD}/2$, $V_{IN} = GND$,

FIGURE 2-19: OutputVoltage Headroom vs. Output Current at $V_{DD} = 1.6V$.

FIGURE 2-20: High-to-Low Propagation Delay Histogram.

FIGURE 2-21: Propagation Delay Skew Histogram.

FIGURE2-22: OutputVoltage Headroom vs. Output Current at VDD = 5.5V.

FIGURE2-23: Low-to-High Propagation Delay Histogram.

FIGURE2-24: Propagation Delay vs. Ambient Temperature.

Note: Unless otherwise indicated, $V_{DD} = +1.6V$ to $+5.5V$, $V_{SS} = GND$, $T_A = +25°C$, $V_{IN} = V_{DD}/2$, $V_{IN} = GND$, R_L = 100 k Ω to $V_{DD}/2$, and C_L = 36 pF.

FIGURE2-25: PropagationDelay vs. **PowerSupply Voltage.**

Capacitance.

FIGURE 2-28: Propagation Delay vs. Input Overdrive.

Frequency.

FIGURE 2-30: Supply Current vs. Toggle

Note: Unless otherwise indicated, $V_{DD} = +1.6V$ to $+5.5V$, $V_{SS} = GND$, $T_A = +25°C$, $V_{IN} = V_{DD}/2$, $V_{IN} = GND$, R_L = 100 k Ω to V_{DD}/2, and C_L = 36 pF.

FIGURE2-31: The HT6541/2/3/4 comparators show no phase reversal.

FIGURE2-32: Supply Current(shoot through current) vs. Chip-Select (CS) Voltage at VDD = 1.6V (HT6543 only).

FIGURE2-33: SupplyCurrent(charging current) vs. Chip-Select (CS) pulse at VDD = 1.6V (HT6543 only).

FIGURE2-34: Chip-Select (\overline{CS}) Step *Response(HT6543only).*

FIGURE2-36: SupplyCurrent(charging current) vs. Chip-Select (CS) pulse at VDD = 5.5V (HT6543 only).

3.1 APPLICATIONS INFORMATION

The HT6541/2/3/4 family of push-pull output comparators are fabricated on Microchip's state-of-the-art CMOS process. They are suitable for a wide range of applications requiring very low power consumption.

3.2 Comparator Inputs

The HT6541/2/3/4 comparator family uses CMOS transistors at the input. They are designed to prevent phase inversion when the input pins exceed the supply voltages. Figure 2-31 shows an input voltage exceeding both supplies with no resulting phase inversion.

The input stage of this family of devices uses two differential input stages in parallel: one operates at low inputvoltagesandtheotherathighinputvoltages.With this topology, the input voltage is 0.3V above V_{DD} and 0.3V below V_{SS} . Therefore, the input offset voltage is measured at both V_{SS} - 0.3V and V_{DD} + 0.3V to ensure proper operation.

The maximum operating input voltages that can be applied are V_{SS} - 0.3V and V_{DD} + 0.3V. Voltages on the inputs that exceed this absolute maximum rating can cause excessive current to flow and permanently damage the device. In applications where the input pin exceeds the specified range, external resistors can be used to limit the current below $±2$ mA, as shown in Figure 3-1.

FIGURE 3-1: An inputresistor(RIN) should be used to limit excessive input current if either of the inputs exceeds the Absolute Maximum specification.

3.3 Push-Pull Output

The push-pull output is designed to be compatible with CMOS and TTL logic, while the output transistors are configured to give rail-to-rail output performance. They are driven with circuitry that minimizes any switching current (shoot-through current from supply-to-supply) when the output is transitioned from high-to-low, or from low-to-high (see Figures 2-15, 2-17, 2-32 through 2-36 for more information).

3.4 HT6543 Chip Select (CS)

The HT6543 is a single comparator with chip select (CS). When \overline{CS} is pulled high, the total current consumption drops to 20 pA (typ); 1 pA (typ) flows through the CS pin, 1 pA (typ) flows through the output pin and 18 pA (typ) flows through the V_{DD} pin, as shown in Figure 1-1. When this happens, the comparator output is put into a high-impedance state. By pulling CS low, the comparator is enabled. If the CS pin is left floating, the comparator will not operate properly. Figure 1-1 shows the output voltage and supply current response to a CS pulse.

The internal \overline{CS} circuitry is designed to minimize glitches when cycling the CS pin. This helps conserve power, which is especially important in batterypowered applications.

3.5 Externally-Set Hysteresis

Greater flexibility in selecting hysteresis (or input trip points) is achieved by using external resistors.

Input offset voltage (V_{OS}) is the center (average) of the (input-referred) low-high and high-low trip points. Input hysteresis voltage (V_{HYST}) is the difference between the same trip points. Hysteresis reduces output chattering when one input is slowly moving past the other and thus reduces dynamic supply current. It also helps in systems where it is best not to cycle between states too frequently (e.g., air conditioner thermostatic control). The HT6541/2/3/4 family has internally-set hysteresis that is small enough to maintain input offset $accuracy$ (<7 mV) and large enough to eliminate output chattering causedby the comparator's owninput noise voltage (200 µVp-p).

3.5.1 NON-INVERTING CIRCUIT

Figure 3-3 shows a non-inverting circuit for singlesupply applications using just two resistors. The resulting hysteresis diagram is shown in Figure 3-4.

FIGURE 3-3: Non-inverting circuit with hysteresis for single-supply.

FIGURE 3-4: Hysteresis Diagram for the Non-Inverting Circuit.

The trip points for Figures 3-3 and 3-4 are:

EQUATION

$$
V_{TLH} = V_{REF} \left(I + \frac{R_I}{R_F} \right) - V_{OL} \left(\frac{R_I}{R_F} \right)
$$

$$
V_{TLL} = V_{REF} \left(I + \frac{R_I}{R_F} \right) - V_{OH} \left(\frac{R_I}{R_F} \right)
$$

$$
V_{TLH} = \text{trip voltage from low to high}
$$

$$
V_{THL} = \text{trip voltage from high to low}
$$

3.5.2 INVERTING CIRCUIT

Figure 3-5 shows an inverting circuit for single-supply using three resistors. The resulting hysteresis diagram is shown in Figure 3-6.

FIGURE 3-6: Hysteresis Diagram for the Inverting Circuit.

In order to determine the trip voltages (V_{THL} and V_{TLH}) for the circuit shown in Figure 3-5, R_2 and R_3 can be simplified to the Thevenin equivalent circuit with respect to V_{DD} , as shown in [Figure](#page-11-0) 3-7.

FIGURE 3-7: Thevenin Equivalent Circuit.

Where:
\n
$$
R_{23} = \frac{R_2 R_3}{R_2 + R_3}
$$
\n
$$
V_{23} = \frac{R_3}{R_2 + R_3} \times V_{DD}
$$

Using this simplified circuit, the trip voltage can be calculated using the following equation:

EQUATION

$$
V_{THL} = V_{OH} \left(\frac{R_{23}}{R_{23} + R_F} \right) + V_{23} \left(\frac{R_F}{R_{23} + R_F} \right)
$$

$$
V_{TLH} = V_{OL} \left(\frac{R_{23}}{R_{23} + R_F} \right) + V_{23} \left(\frac{R_F}{R_{23} + R_F} \right)
$$

 V_{T1H} = trip voltage from low to high

 V_{THL} V_{THL} [=](#page-7-0) trip voltage [from](#page-7-1) high to low

Figure 2-19 and Figure 2-22 can be used to determine typical values for V_{OH} and V_{OL} .

3.5 Bypass Capacitors

With this family of comparators, the power supply pin $(V_{DD}$ for single supply) should have a local bypass capacitor (i.e., $0.01 \mu F$ to $0.1 \mu F$) within 2 mm for good edge rateperformance.

3.6 Capacitive Loads

Reasonable capacitive loads (e.g., logic gates) have little impact on propagation delay (see Figure 2-27). The supply current increases with increasing toggle frequency (Figure 2-30), especially with higher capacitive loads.

3.7 Battery Life

In order to maximize battery life in portable applications, use large resistors and small capacitive loads. Also, avoid toggling the output more than necessary and do not use chip select (CS) to conserve power for short periods of time. Capacitive loads will draw additional power at start-up.

3.8 PCB Surface Leakage

In applications where low input bias current is critical, PCB (Printed Circuit Board) surface leakage effects need to be considered. Surface leakage is caused by humidity, dust or other contamination on the board. Under low humidity conditions, a typical resistance between nearby traces is 10¹² Ω . A 5V difference would cause 5 pA, if current-to-flow. This is greater than the HT6541/2/3/4 family's bias current at 25°C (1 pA, typ).

The easiest way to reduce surface leakage is to use a guard [ring](#page-12-0) around sensitive pins (or traces). The guard ring is biased at the same voltage as the sensitive pin. An example of this type of layout is shown in Figure 3-8.

FIGURE3-8: ExampleGuardRingLayout forInverting Circuit.

- 1. Inverting Configuration (Figures 3-5 and 3-8):
	- a. Connect the guard ring to the non-inverting input pin $(V_{IN}+)$. This biases the guard ring to the same reference voltage as the comparator (e.g., $V_{DD}/2$ or ground).
	- b. Connect the inverting pin $(V_{IN}-)$ to the input pad without touching the guard ring.
- 2. Non-inverting Configuration (Figure 3-3):
	- a. Connect the non-inverting pin $(V_{\text{IN}}+)$ to the input pad without touching the guard ring.
	- b. Connect the guard ring to the inverting input pin $(V_{IN}-)$.

3.9 Typical Applications

3.9.1 PRECISE COMPARATOR

Some applications require higher DC precision. An easy way to solve this problem is to use an amplifier (such as the HT6041) to gain-up the input signal before it reaches the comparator. Figure 3-9 shows an example of this approach.

FIGURE3-9: Precise Inverting Comparator.

3.9.2 WINDOWED COMPARATOR

Figure 3-10 shows one approach to designing a windowed comparator. The AND gate produces a logic '1' when the input voltage is between V_{RB} and V_{RT} (where V_{RT} > V_{RB}).

FIGURE 3-10: WindowedComparator.

3.9.3 BISTABLE MULTI-VIBRATOR

A simple bistable multi-vibrator design is shown in Figure 3-11. V_{REF} needs to be between the power supplies (V_{SS} = GND and V_{DD}) to achieve oscillation. The output duty cycle changes with V_{REF} .

FIGURE 3-11: Bistable Multi-vibrator.

5-Lead Plastic Package (LT) (SC-70)

*Controlling Parameter

Notes:

Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .005" (0.127mm) per side.

JEITA (EIAJ) Standard: SC-70 Drawing No. C04-061

5-Lead Plastic Small Outline Transistor (OT) (SOT23)

* Controlling Parameter § Significant Characteristic

Notes:

Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" (0.254mm) per side. JEDEC Equivalent: MO-178

8-Lead Plastic Dual In-line (P) – 300 mil (PDIP)

* Controlling Parameter

§ Significant Characteristic

Notes:

Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" (0.254mm) per side. JEDEC Equivalent: MS-001

8-Lead Plastic Small Outline (SN) – Narrow, 150 mil(SOIC)

* Controlling Parameter

§ Significant Characteristic

Notes:

Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" (0.254mm) per side. JEDEC Equivalent: MS-012

8-Lead Plastic Micro Small Outline Package (MS) (MSOP)

*Controlling Parameter

Notes:

Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" (0.254mm) per side.

JEDEC Equivalent: MO-187

14-Lead Plastic Dual In-line (P) – 300 mil (PDIP)

* Controlling Parameter

§ Significant Characteristic

Notes: Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" (0.254mm) per side.

JEDEC Equivalent: MS-001 Drawing No. C04-005

14-Lead Plastic Small Outline (SL) – Narrow, 150 mil(SOIC)

L

* Controlling Parameter

§ Significant Characteristic

 β

Notes:

Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .010" (0.254mm) per side. JEDEC Equivalent: MS-012

14-Lead Plastic Thin Shrink Small Outline (ST) – 4.4 mm (TSSOP)

* Controlling Parameter

§ Significant Characteristic

Notes:

Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed .005" (0.127mm) per side. JEDEC Equivalent: MO-153 Drawing No. C04-087